

<b>Notice of References Cited</b>	Application/Control No. 10/691,378	Applicant(s)/Patent Under Reexamination OH ET AL.	
	Examiner Gary Mui	Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,180,910	02-2007	Kim et al.	370/468
*	B	US-6,546,014	04-2003	Kramer et al.	370/395.41
*	C	US-6,804,256	10-2004	Chang, Tsung-Shien	370/468
*	D	US-2003/0133460	07-2003	Lee et al.	370/395.43
*	E	US-2003/0170032	09-2003	Song et al.	398/168
*	F	US-2003/0179769	09-2003	Shi et al.	370/442
*	G	US-2004/0052274	03-2004	Wang et al.	370/468
*	H	US-2004/0141759	07-2004	Stiscia et al.	398/168
*	I	US-2006/0013138	01-2006	Haran et al.	370/236
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.